

PROCEEDINGS OF SPIE

Damage to VUV, EUV, and X-ray Optics V

**Libor Juha
Saša Bajt
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Editors

**15–16 April 2015
Prague, Czech Republic**

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Published By
SPIE

Volume 9511

Proceedings of SPIE 0277-786X, V. 9511

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

Damage to VUV, EUV, and X-ray Optics V, edited by Libor Juha, Saša Bajt
Richard London, Proc. of SPIE Vol. 9511, 951101 · © 2015 SPIE
CCC code: 0277-786X/15/\$18 · doi: 10.1117/12.2199434

Proc. of SPIE Vol. 9511 951101-1

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Author(s), "Title of Paper," in *Damage to VUV, EUV, and X-ray Optics V*, edited by Libor Juha, Saša Bajt, Richard London, Proceedings of SPIE Vol. 9511 (SPIE, Bellingham, WA, 2015) Article CID Number.

ISSN: 0277-786X

ISBN: 9781628416329

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA

Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445

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